Seminar on Climatic Reliability of Electronics: Global Challenges and Perspectives

5-6 March 2020

Technical University of Denmark











PROGRAMME Thursday 5 March 2020

08:30-09:00	Registration and breakfast	
	Session 1 – Humidity interaction with PCBA and failure mechanisms	
09:00-09:30	Overview of the seminar, and some perspectives on the humidity effects on electronics Rajan Ambat, CELCORR, DTU	
09:30-10:00	Corrosion behavior of printed electronics with silver traces Laura Frisk, Trelic	
10:00-10:30	Corrosion investigations on Bi and Mn micro-alloyed lead-free SAC alloys Bálint Medgyes, BME	
10:30-11:00	Break	
11:00-11:30	Electrochemical corrosion and thermal effects at voltages ≥ 12 V in electronics systems Nicolas Mayer, Automotive Electronics Robert Bosch	
11:30-12:00	Carbonization of PCB material in relation to thermal incidents Lutz Müller, Automotive Electronics Robert Bosch	
12:00-13:00	Lunch	
	Session 2 – Importance of process and service related residues	
13:00-13:30	Interaction of PCBA Materials and flux systems: Reli- ability assement Daniel Buckland, Henkel Ltd. Climatic Reliability of Electronics 2	

13:30-14:00	Does the measurement of ionic contamination predict reliability? Realization of IPC-J-STD001G-Am1 in the automotive Industry Lothar Henneken, Automotive Electronics Robert Bosch
14:00-14:30	A validation tool for SMT-flux residues by infra- red-spectroscopy based multi variate data analysis Theresia Richter, Automotive Electronics Robert Bosch
14:30-15:00	Chemical composition, evolution, deliquescence and conductivity of aerosol deposited on the insulators of the Italian national power lines Luca Ferrero, University of Milan Biccoca
15:00-15:30	Break Session 3 – Humidity and reliability of high power/low power systems and components
15:30-16:00	Studies on sprayed metal (schoopage) as humidity barri- er in film capacitor <i>Lucia Cabo</i> , TDK Electronics Components
16:00-16:30	Beyond humidity testing: Mixed Flowing Gas Tests on Power Electronics Tommi Kärkkäinen, LUT University in Lappeenranta
16:30-17:00	Humidity-induced failures in state-of-the-art power semiconductor devices Christian Zorn, University of Bremen



PROGRAMME Friday 6 March 2020

08:15-08:30	Arrival and breakfast
	Session 3 (continued) – Humidity and reliability of high power/low power systems and components
08:30-09:00	Comparison of PCBs and DBCs concerning ECM and formation of dendrites Chen Weiyi, Fraunhofer Institute for Integrated Systems and Device Technology IISB
09:00-09:30	Field failures of electronics and power capacitors in railway application: Breakdowns related to environ- mental conditions and proposed countermeasures Roland Schmid, Bombardier Transportation
09:30-10:00	Study of the degradation of different thermoelectric modules at Teide volcano Leyre Catalán Ros, Universidad Pública de Navarra
10:00-10:30	Challenges and requirements for reliable sinter inter- connections Markus Meier, Zestron
10:30-11:00	Break
	Session 4 – Humidity robustness testing, characteri- zation methods and standards
11:00-11:30	Alternative Detection methods for Humidity Impacts on PCBAs Simone Lauser, Automotive Electronics Robert Bosch

Climatic Reliability of Electronics | 4

11.30-12:00	Complementary EIS / FTIR study of the degradation of adhesives in electronic packaging Michael Schneider, Fraunhofer-Institut für Keramische Tech- nologien und Systeme IKTS
12:00-13:00	Lunch
13:00-13:30	Component Specific Test Boards and Electrical Test Meth- ods for Assessing the Climatic Reliability of PCBAs Mike Bixenman, Kyzen
13:30-14:00	Reliability standards for cleanliness and coating: Pro- tecting the future Emma Hudson, GEN3 Systems
	Session 5 - Extrinsic methods for prevention of humidity effects
14:00-14:30	Mission profiling and corrosion classification: impor- tance in relation to humidity effects on electronics Morten Jellesen, CELCORR, DTU
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14:00-14:30 14:30-15:00 15:00-15:30	Mission profiling and corrosion classification: impor- tance in relation to humidity effects on electronics Morten Jellesen, CELCORR, DTU Break Ultra-thin Fluoropolymer Coating: Performance and its use in Electronics Mélanie Mathon, Inventec Performance Chemicals
14:00-14:30 14:30-15:00 15:00-15:30 15:30-16:00	Mission profiling and corrosion classification: impor- tance in relation to humidity effects on electronics Morten Jellesen, CELCORR, DTU Break Ultra-thin Fluoropolymer Coating: Performance and its use in Electronics Mélanie Mathon, Inventec Performance Chemicals Moisture absorption by polymer materials and impact on enclosure design Helene Conseil/Sankhya Mohanty, CELCORR, DTU

5 | Climatic Reliability of Electronics



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Feknologisk Videndeling ATV-SEMAPP.DK

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This seminar is organized by Centre for Electronic Corrosion (CELCORR), DTU and European Federation of Corrosion, Working Party 23 on "Corrosion Reliability of Electronics", EFC event No. 457

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